

Diode Laser System for Laser Wafer Annealing

DLight®S Series



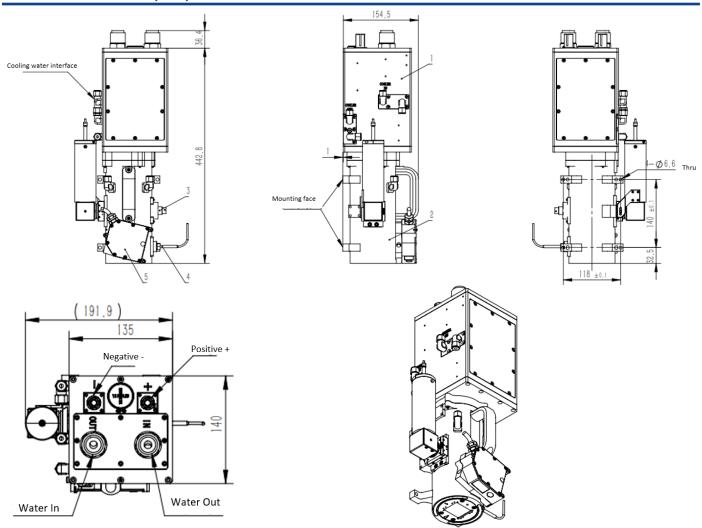
Features

- Narrow beam width
- High power density
- Modular design, easy maintenance
- High product consistency
- Multiple additional functions

Applications

- · Dynamic surface annealing
- Laser spike annealing
- · Film annealing
- · Material surface treatment

Product Dimensions (mm)



Remark: The structure drawing is only for reference. For any other special requirement, please feel free to contact us.



Product Specifications

| Product Code Part No. 1 | | (Typical Customization) FL - DLight - S1500A |
|---|-------|--|
| Optical Parameters ² | Unit | |
| Operation Mode | - | CW |
| Max Output Power ³ | W | 1500 |
| Standard Output Power ⁴ | W | 1050 |
| Power Stability | % | ≤ ± 2 |
| Wavelength | nm | 808 |
| Wavelength Tolerance | nm | ±5 |
| Beam Length: Top-hat Area | mm | 11.5 ± 0.5 |
| Beam Length: Beam Profile | - | Top hat |
| Beam Length: Uniformity ⁵ | % | ≥ 95 |
| Beam width: FWHM | μm | 70 ± 5 |
| Beam width: Beam Profile | - | Gaussian |
| Beam width: Stability | μm | ≤ ± 1 |
| Working Distance | mm | 45-50 |
| Depth of Focus ⁶ | μm | ± 80 |
| Working Parameters | | |
| Operating Current | А | ≤ 100 |
| Operating Voltage | V | ≤ 40 |
| Impact resistance | g | ≥ 1 |
| Laser system motion Velocity: Working surface | mm/s | ≤ 500 |
| Laser system motion Velocity: Focus Axis | mm/s | ≤ 10 |
| Ambient Parameters ⁷ | | |
| Operating Temperature | °C | 25 |
| Storage Temperature | °C | 5 ~ 45 |
| Cooling Method | - | DI Water cooling |
| DI Water Quality | μS/cm | 2 ~ 5 |
| Product Configuration 8 | | |
| Dimensions (height × width × depth) | mm | 480 x 155 x 192 |
| System Configuration | F | Power Supply/Controller/Cooling System |
| Optional Configuration | | Pyrometer / Beam quality analysis system / Power meter |

Part No. = Brand Code - Series - Power - Configuration.

⁸ Product configuration can be customized.



 $^{^{\}rm 2}\,{\rm Data}$ at operating temperature, unless otherwise stated.

³ Reduced lifetimes if used above Max output power.

⁴ All parameters are tested under the standard output power .

 $^{^{\}rm 5}$ The uniformity judgment standard complies with ISO 13694-2018.

 $^{^{\}rm 6}$ Depth of Focus for 5% change of beam length or width.

 $^{^{7}\,\}mathrm{A}$ non-condensing environment is required for storage and operation below ambient dew point.